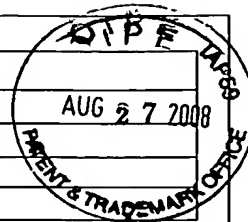


**SECOND
INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet 1 of 1

Application Number	10/540,886
Filing Date	December 29, 2005
First Named Inventor	Masakazu Ohara et al.
Examiner Name	HOA T LE
Attorney Docket No.	1033634-000003



U.S. PATENT DOCUMENTS

Examiner Initials	Document Number-Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Figures Appear
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Examiner Initials	Foreign Patent Document	Publication Date (MM-DD-YYYY)	Name of Patentee or Applicant of Cited Document	STATUS							
	Country Code ¹ , Number, Kind Code			Translation	Partial Translation	Eng. Lang. Summary	Search Report	IPER	Abstract	Cited in Spec. / Pg. No(s).	
	EP 0 285 450A	10-05-1988	Akira Yoshizumi et al.				X				
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	JP 08-188822	07-23-1996	Masato Fujioka et al.		X						

¹Enter Office that issued the document, by the two-letter code.

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	D. W. SCHAEFER et al., "Fractal geometry of colloidal aggregates," PHYSICAL REVIEW LETTERS USA, Vol. 52, No. 26, pp. 2371-2374, June 25, 1984
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Examiner Signature	Date Considered
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.